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MOSFET - Power, N-Channel, PowerTrench[®] Power Clip, Symmetric Dual ^{30 V} NTTFD2D8N03P1E

Features

- Small Footprint (3.3mm x 3.3mm) for Compact Design
- Low R_{DS(on)} to Minimize Conduction Losses
- $\bullet \ Low \ Q_G$ and Capacitance to Minimize Driver Losses
- These Devices are Pb-Free and are RoHS Compliant

Typical Applications

- DC-DC Converters
- System Voltage Rails

MAXIMUM RATINGS (T_J = 25°C unless otherwise noted)

Para	neter		Symbol	Q1	Q2	Unit
Drain-to-Source Volt	age		V _{DSS}	30	30	V
Gate-to-Source Volta	age		V _{GS}	+16 -12	+16 -12	V
Continuous Drain Current $R_{\theta,IC}$		$T_C = 25^{\circ}C$	Ι _D	80	80	А
(Note 3)	Steady	$T_C = 85^{\circ}C$		58	58	
Power Dissipation $R_{\theta JC}$ (Note 3)	State	$T_A = 25^{\circ}C$	P _D	26	26	W
Continuous Drain Current $R_{\theta,IA}$		$T_A = 25^{\circ}C$	Ι _D	21.1	21.1	А
(Notes 1, 3)	Steady	$T_A = 85^{\circ}C$		15.2	15.2	
Power Dissipation $R_{\theta JA}$ (Notes 1, 3)	State	$T_A = 25^{\circ}C$	PD	1.79	1.79	W
Continuous Drain		$T_A = 25^{\circ}C$	I _D	16.1	16.1	А
Current R _{θJA} (Notes 2, 3)	Steady	$T_A = 85^{\circ}C$		11.6	11.6	
Power Dissipation $R_{\theta JA}$ (Notes 2, 3)	State	$T_A = 25^{\circ}C$	P _D	1.04	1.04	W
Pulsed Drain Current	T _A = 25°0	C, t _p = 10 μs	I _{DM}	327	356	А
Single Pulse Drain-to-Source Avalanche Energy Q1: $I_L = 33.3 A_{pk}$, L = 0.1 mH (Note 4) Q2: $I_L = 34.3 A_{pk}$, L = 0.1 mH (Note 4)			E _{AS}	55.4	58.8	mJ
Operating Junction and	Junction and Storage Temperature			-55 to	+ 150	°C
Lead Temperature for Purposes (1/8" from			ΤL	26	60	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

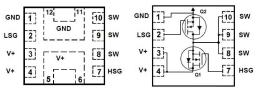
- 1. Surface-mounted on FR4 board using a 1 in² pad size, 2 oz. Cu pad.
- 2. Surface-mounted on FR4 board using minimum pad size, 2 oz. Cu pad.
- 3. The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted. Actual continuous current will be limited by thermal & electro-mechanical application board design. R_{θJC} is determined by the user's board design.
- 4. Q1 100% UIS tested at L = 0.1 mH, IAS = 21.1 A.

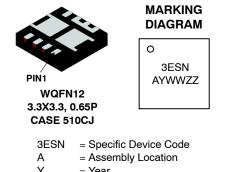
Q2 100% UIS tested at L = 0.1 mH, IAS = 21.1 A.

5. This device is Class 1B ESD HBM Rating.

FET	V _{(BR)DSS}	R _{DS(ON)} MAX	I _D MAX
Q1	30 V	$2.5~\mathrm{m}\Omega$ @ 10 V	80 A
GI	30 V	$3.0~\text{m}\Omega$ @ $4.5~\text{V}$	60 A
Q2	30 V	$2.5~\mathrm{m}\Omega$ @ 10 V	80 A
Q2	30 V	$3.0~\text{m}\Omega$ @ $4.5~\text{V}$	60 A

ELECTRICAL CONNECTION





=	Year	

WW = Work Week

ΖZ

= Assembly Lot Code

ORDERING INFORMATION

Device	Package	Shipping [†]
NTTFD2D8N03P1E	WQFN12 (Pb-Free)	3000 / Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

1

THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Q1 Max	Q2 Max	Unit
Junction-to-Case - Steady State (Notes 1, 3)	$R_{ heta JC}$	4.8	4.8	°C/W
Junction-to-Ambient - Steady State (Notes 1, 3)	$R_{ hetaJA}$	70	70	
Junction-to-Ambient - Steady State (Notes 2, 3)	$R_{\theta JA}$	120	120	

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise specified)

Parameter	Symbol	Test Condition	FET	Min	Тур	Max	Unit
OFF CHARACTERISTICS							

OIT ONANAOTENISTICS								
Drain-to-Source Breakdown	$V_{(BR)DSS}$ $V_{GS} = 0 V, I_D = 1 mA$		1 mA	Q1	30			V
Voltage		V_{GS} = 0 V, I _D =	1 mA	Q2	30			v
Drain-to-Source Breakdown	V _{(BR)DSS} /	I _D = 1 mA, ref to	≥25°C	Q1		17.9		m)//°C
Voltage Temperature Coefficient	IJ	I _D = 1 mA, ref to	≥25°C	Q2		17.2	mV/°C	
Zero Gate Voltage Drain Current	I _{DSS}	$V_{GS} = 0 V,$	$T_J = 25^{\circ}C$	Q1			1.0	
		V _{DS} = 24 V		Q2			1.0	μΑ
Gate-to-Source Leakage	I _{GSS}	$V_{DS} = 0 V, V_{GS} = +1$	6 V / -12 V	Q1			±100	-
Current		V _{DS} = 0 V, V _{GS} = +1	6 V / –12 V	Q2			±100	nA

ON CHARACTERISTICS (Note 6)

Gate Threshold Voltage	V _{GS(TH)}	V_{GS} = V_{DS} , I_D = 400 μ A	Q1	1.2		2.2	v
		V_{GS} = V_{DS} , I_D = 400 μ A	Q2	1.2		2.2	v
Negative Threshold Temperature Coefficient	V _{GS(TH)} /T _J	I_D = 400 µA, ref to 25°C	Q1		-4.3		
		I_D = 400 µA, ref to 25°C	Q2		-4.5		mV/°C
Drain-to-Source On Resistance	R _{DS(on)}	V_{GS} = 10 V, I _D = 18 A	Q1		2.0	2.5	
		V_{GS} = 4.5 V, I _D = 16 A			2.6	3.0	
		V_{GS} = 10 V, I _D = 18 A	Q2		1.8	2.5	mΩ
		V_{GS} = 4.5 V, I _D = 16 A			2.4	3.0	
Forward Transconductance	g fs	$V_{DS} = 5 \text{ V}, \text{ I}_{D} = 18 \text{ A}$	Q1		129		0
		$V_{DS} = 5 \text{ V}, \text{ I}_{D} = 18 \text{ A}$	Q2		141		S
Gate-Resistance	R _G	$T_A = 25^{\circ}C$	Q1		0.68		
			Q2		0.75		Ω

CHARGES, CAPACITANCES & GATE RESISTANCE

Input Capacitance	C _{ISS}		Q1	1500	~ F
			Q2	1521	pF
Output Capacitance	C _{OSS}		Q1	483	рF
		V _{GS} = 0 V, V _{DS} = 15 V, f = 1 MHz	Q2	498	pΓ
Reverse Transfer Capacitance	C _{RSS}		Q1	29	рF
			Q2	22	рг

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions. 6. Pulse Test: pulse width $\leq 300 \ \mu$ s, duty cycle $\leq 2\%$.

7. Switching characteristics are independent of operating junction temperatures.

ELECTRICAL CHARACTERISTICS (T_J = 25° C unless otherwise specified)

Parameter	Symbol	Test Condition	FET	Min	Тур	Max	Unit		
CHARGES, CAPACITANCES & GATE RESISTANCE									
Total Gate Charge	Q _{G(TOT)}		Q1		9.5		nC		
			Q2		9.3		nc		
Gate-to-Drain Charge	Q _{GD}	Q1: V _{GS} = 4.5 V, V _{DS} = 15 V; I _D = 18 A	Q1		2.0		nC		
		Q2: V_{GS} = 4.5 V, V_{DS} = 15 V; I_{D} = 18 A	Q2		1.6		ne		
Gate-to-Source Charge	Q _{GS}]	Q1		3.7		nC		
			Q2		3.7		nc		
Total Gate Charge	Q _{G(TOT)}	Q1: V_{GS} = 10 V, V_{DS} = 15 V; I_{D} = 18 A	Q1		20.8		nC		
		Q2: V_{GS} = 10 V, V_{DS} = 15 V; I_{D} = 18 A	Q2		20.5		nc		

SWITCHING CHARACTERISTICS, VGS = 4.5 V (Note 7)

Turn-On Delay Time	t _{d(ON)}		Q1	13	20
			Q2	13.3	ns
Rise Time	t _r		Q1	5.5	20
		$V_{GS} = 4.5 V$ Q1: I _D = 18 A, V _{DD} = 15 V, R _G = 6 Ω	Q2	5.8	ns
Turn-Off Delay Time	t _{d(OFF)}	Q2: $I_D = 18 \text{ A}, V_{DD} = 15 \text{ V}, H_G = 6 \Omega$	Q1	18.9	20
			Q2	19	ns
Fall Time	t _f		Q1	5.5	20
			Q2	5.5	ns

SWITCHING CHARACTERISTICS, VGS = 10 V (Note 7)

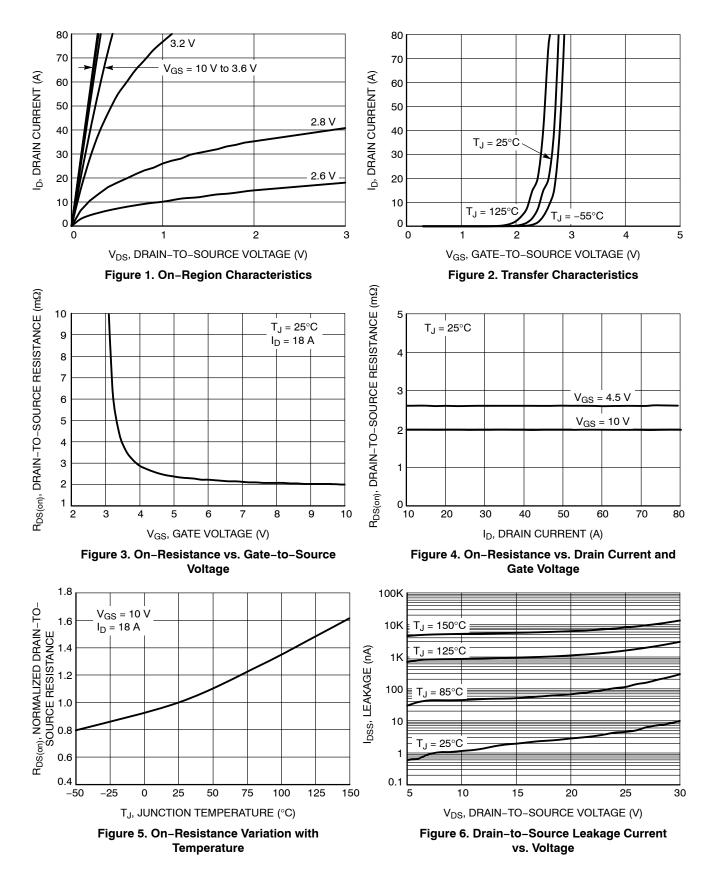
Turn-On Delay Time	t _{d(ON)}		Q1	8.4	20
			Q2	8.7	ns
Rise Time	t _r		Q1	2	20
		V_{GS} = 10 V Q1: I _D = 18 A, V _{DD} = 15 V, R _G = 6 Ω	Q2	2	ns
Turn-Off Delay Time	t _{d(OFF)}	Q1. ID = 18 A, V_{DD} = 15 V, R_{G} = 0 Ω Q2: I _D = 18 A, V_{DD} = 15 V, R_{G} = 6 Ω	Q1	26.3	20
			Q2	26.3	ns
Fall Time	t _f		Q1	3.8	20
			Q2	3.6	ns

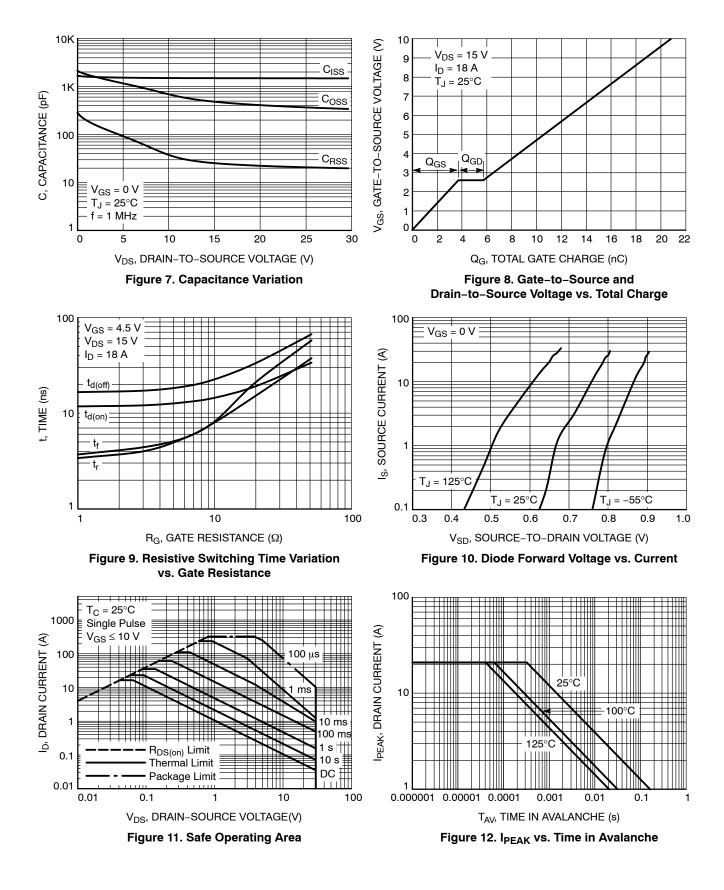
DRAIN-SOURCE DIODE CHARACTERISTICS

Forward Diode Voltage	V _{SD}	V _{GS} = 0 V, I _S = 18 A	$T_J = 25^{\circ}C$	Q1	0.8	1.2	v
			T _J = 125°C		0.67		
		V _{GS} = 0 V, I _S = 18 A	$T_J = 25^{\circ}C$	Q2	0.8	1.2	v
		I _S = 18 A	T _J = 125°C		0.66		
Reverse Recovery Time	t _{RR}	V _{GS} = 0 V, V _{DD} = 15 V Q1: I _S = 18 A, dI _S /dt = 100 A/μs		Q1	30		
				Q2	29		ns
Reverse Recovery Charge	Q _{RR}	Q2: $I_S = 18 \text{ A}, dI_S/dt = Q2: I_S = 18 \text{ A}, dI_S = 18 \text{ A}, dI_S = 18 \text{ A}, dI_S = 18 $	Q1	13			
				Q2	12.5		nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

6. Pulse Test: pulse width $\leq 300 \ \mu$ s, duty cycle $\leq 2\%$. 7. Switching characteristics are independent of operating junction temperatures.





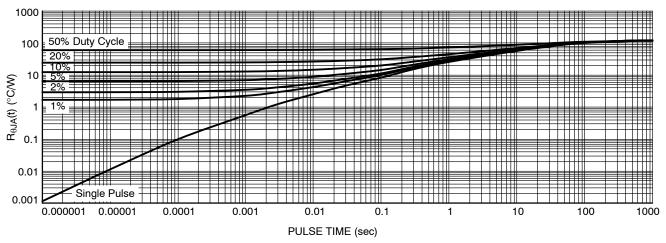
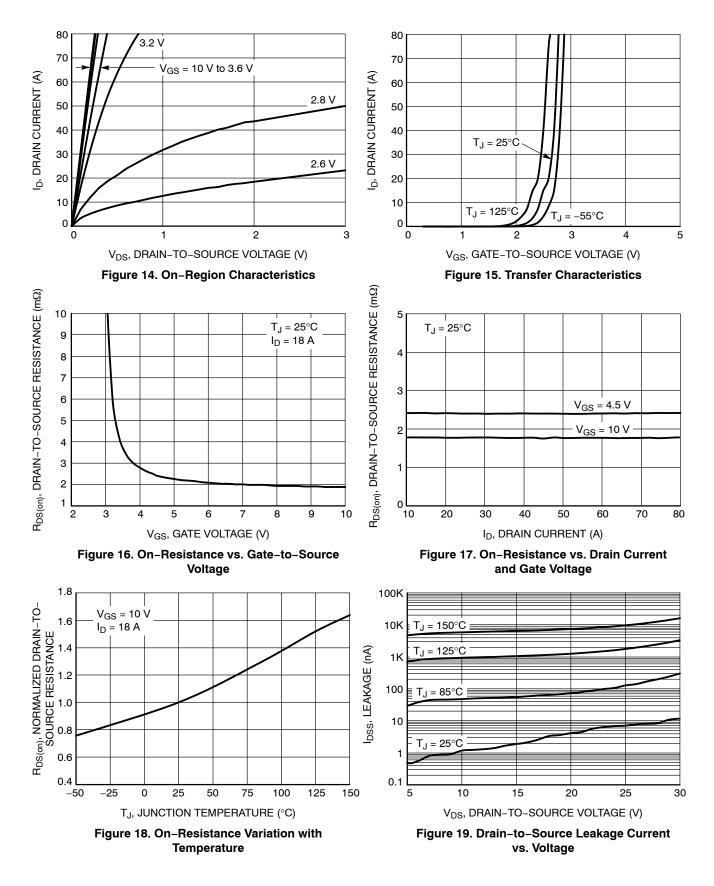
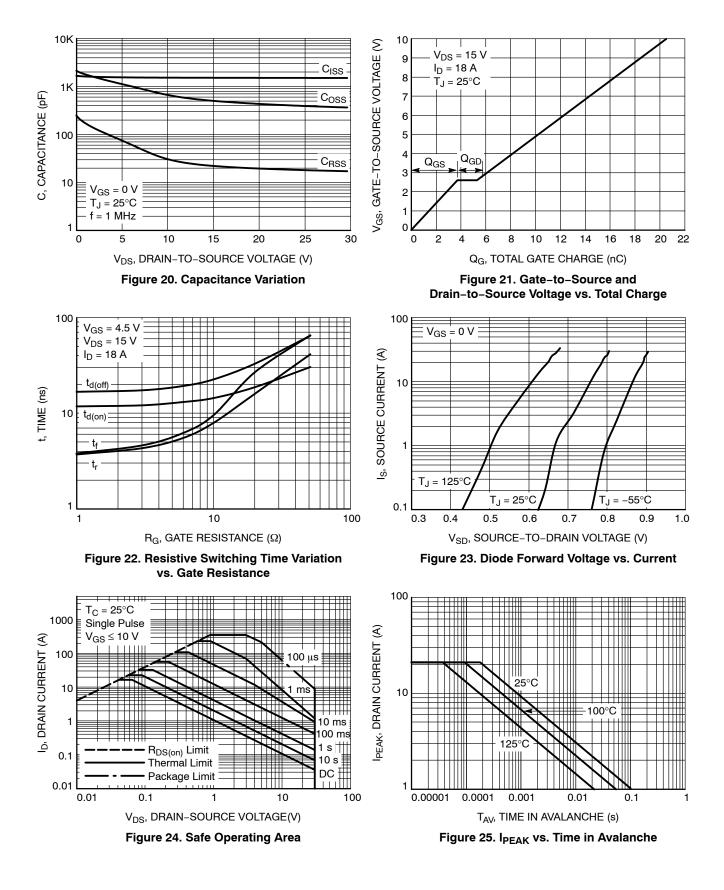


Figure 13. Thermal Characteristics





TYPICAL CHARACTERISTICS – Q2

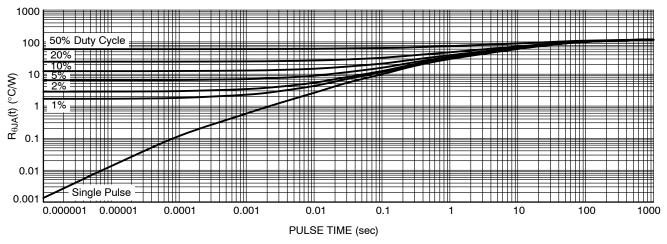
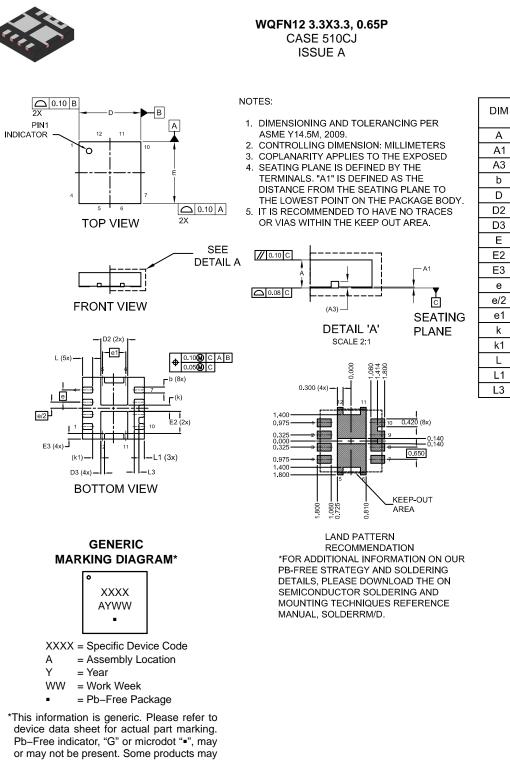


Figure 26. Thermal Characteristics

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NOM MAX

MILLIMETERS

MIN

A	0.70	0.75	0.80			
A1	0.00		0.05			
A3	0.20 REF					
b	0.27 0.32		0.37			
D	3.20	3.30	3.40			
D2	1.34	1.44	1.54			
D3	0.10	0.20	0.30			
Е	3.20	3.30	3.40			
E2	1.09	1.19	1.29			
E3	0.20	0.30	0.40			
е	0.65 BSC					
e/2	0.325 BSC					
e1	1.24 BSC					
k	0.33 REF					
k1	0.43 REF					
L	0.44	0.54	0.64			
L1	0.19	0.29	0.39			
L3	0.15	0.25	0.35			

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